

Date: January 19, 2004

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Form PTO-1449 (REV. 07/01)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE CITATION <i>(Use several sheets if necessary)</i>			ATTY. DOCKET NO. COLB-119AX	APPLICATION NO. 10/761,023	
					APPLICANT: Boris Yokhin, et al.		
					FILING DATE Herewith	TC ART UNIT	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE*
IK		5,740,226**	4/14/1998	Komiya, et al.	378	70	
IK		5,619,548**	4/8/1997	Koppel	378	70	
IK		5,923,720**	7/13/1999	Barton, et al.	378	84	
IK		6,381,303 B1**	4/30/2002	Vu, et al.	378	46	
IK		6,389,102 B2**	5/14/2002	Mazor, et al.	378	89	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)							
IK		Wiener, et al., "Characterization of Titanium Nitride Layers by Grazing-Emission X-Ray Fluorescence Spectrometry", Applied Surface Science 125 (1998), pp. 129-136					
EXAMINER	<i>Sakli Kibwadre</i>				DATE CONSIDERED		
					09/14/2004		
*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

CGL/mc/300833-1

****REFERENCES CAN BE FOUND IN PARENT APPLICATION NO. 10/078,640 filed February 19, 2002**